Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/715,031	E. ZAISER ET AL.
Examiner	Art Unit

3771

Teena Mitchell

SEARCHED				
Class	Subclass	Date	Examiner	
128	201.21 201.26 202.27 203.21			
	20418 81140C			
	204.25			
	205.24		-	
137	505, 25 505			
	505 505 78 567 368			
25	368			

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
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